

## **AOT11N70-VB Datasheet**

## N-Channel 700V (D-S) Super Junction Power MOSFET

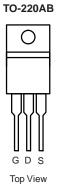
PRODUCT SUMMARY				
V <sub>DS</sub> (V) at T <sub>J</sub> max.	700			
R <sub>DS(on)</sub> at 25 °C (Ω)	V <sub>GS</sub> = 10 V 0.75			
Q <sub>g</sub> max. (nC)	23			
Q <sub>gs</sub> (nC)	2.3			
Q <sub>gd</sub> (nC)	15			
Configuration	Single			

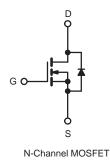
#### **FEATURES**

- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Ultra low gate charge (Q<sub>q</sub>)
- Avalanche energy rated (UIS)

#### **APPLICATIONS**

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Industrial





= 25 °C, unless otherwis	se noted)			
PARAMETER			UNIT	
Drain-Source Voltage			V	
	V <sub>GS</sub>	± 30	V	
50 °C) $V_{GS}$ at 10 V $T_C = 25 °C$ $I_D$		7		
$T_{\rm C} = 100 ^{\circ}{\rm C}$	١D	5.9	А	
Pulsed Drain Current <sup>a</sup>				
Linear Derating Factor			W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			mJ	
Maximum Power Dissipation			W	
Operating Junction and Storage Temperature Range		-55 to +150	°C	
Drain-Source Voltage Slope $T_J = 125 \text{ °C}$		50	V/ns	
Reverse Diode dV/dt <sup>d</sup>		3.2		
for 10 s		300	°C	
	$V_{GS} \text{ at } 10 \text{ V} \qquad \frac{T_{C} = 25 \text{ °C}}{T_{C} = 100 \text{ °C}}$ $T_{J} = 125 \text{ °C}$	$\begin{array}{c c} V_{GS} \mbox{ at } 10 \mbox{ V} & \hline T_{C} = 25 \ ^{\circ}\mbox{C} & I_{D} & \hline \\ \hline T_{C} = 100 \ ^{\circ}\mbox{C} & I_{DM} & \\ & & & \\ & & & \\ \hline & & & \\ & & & \\ \hline & & & \\ E_{AS} & & \\ \hline & & & \\ P_{D} & & \\ e & & & T_{J}, T_{stg} & \\ \hline & & & & \\ T_{J} = 125 \ ^{\circ}\mbox{C} & & \\ dV/dt & & \\ \hline \end{array}$	$\begin{tabular}{ c c c c c c } \hline $SYMBOL$ & $LIMIT$ \\ $V_{DS}$ & $700$ \\ $V_{GS}$ & $\pm$30$ \\ \hline $T_C = 25\ ^{\circ}C$ & $I_D$ & $7$ \\ \hline $I_D$ & $12$ \\ \hline $I_C = 100\ ^{\circ}C$ & $I_D$ & $12$ \\ \hline $I_C = 100\ ^{\circ}C$ & $I_D$ & $12$ \\ \hline $I_C = 100\ ^{\circ}C$ & $I_D$ & $12$ \\ \hline $I_C = 100\ ^{\circ}C$ & $I_D$ & $12$ \\ \hline $I_C = 100\ ^{\circ}C$ & $I_D$ & $12$ \\ \hline $I_C = 100\ ^{\circ}C$ & $I_D$ & $12$ \\ \hline $I_C = 100\ ^{\circ}C$ & $I_D$ & $12$ \\ \hline $I_C = 100\ ^{\circ}C$ & $I_D$ & $12$ \\ \hline $I_C = 100\ ^{\circ}C$ & $I_D$ & $12$ \\ \hline $I_C = 100\ ^{\circ}C$ & $I_D$ & $12$ \\ \hline $I_C = 100\ ^{\circ}C$ & $I_D$ & $12$ \\ \hline $I_C = 100\ ^{\circ}C$ & $I_D$ & $12$ \\ \hline $I_C = 100\ ^{\circ}C$ & $I_D$ & $12$ \\ \hline $I_C = 100\ ^{\circ}C$ & $I_D$ & $12$ \\ \hline $I_C = 100\ ^{\circ}C$ & $I_D$ & $12$ \\ \hline $I_C = 100\ ^{\circ}C$ & $I_D$ & $I_C$ & $I_C$ & $I_C$ & $I_C$ \\ \hline $I_C = 100\ ^{\circ}C$ & $I_D$ & $I_C$ & $I$	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature. b.  $V_{DD} = 50$  V, starting T<sub>J</sub> = 25 °C, L = 28.2 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 3.5 A.

c. 1.6 mm from case. d.  $I_{SD} \leq I_D$ , dl/dt = 100 A/µs, starting  $T_J$  = 25 °C.





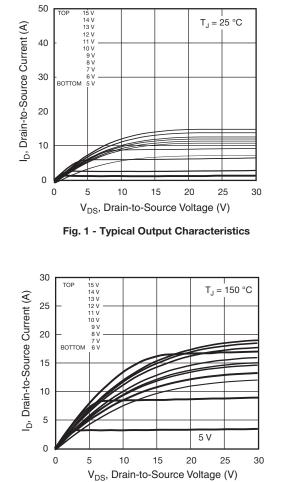
THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	72	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.7	C/ W

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static				•	•		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> =	= 0 V, I <sub>D</sub> = 250 μΑ	700	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I <sub>D</sub> = 1 mA	-	0.65	-	V/°C
Gate-Source Threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μΑ	2	-	4	V
	I <sub>GSS</sub>	$V_{GS} = \pm 20 \text{ V}$		-	-	± 100	nA
Gate-Source Leakage			$V_{GS} = \pm 30 \text{ V}$		-	± 1	μA
		V <sub>DS</sub> =	= 700 V, V <sub>GS</sub> = 0 V	-	-	1	μΑ
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		/, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	10	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	$I_D = 4 A$	-	0.75	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub>	= 30 V, I <sub>D</sub> = 4 A	-	17	-	S
Dynamic		_					1
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V,	-	366	-	
Output Capacitance	C <sub>oss</sub>		$V_{\rm DS} = 100 \text{ V},$	-	27	-	1
Reverse Transfer Capacitance	C <sub>rss</sub>		f = 1  MHz		13	-	pF
Effective Output Capacitance, Energy Related <sup>a</sup>	C <sub>o(er)</sub>	- V <sub>DS</sub> = 0 V to 520 V, V <sub>GS</sub> = 0 V		-	46	-	
Effective Output Capacitance, Time Related <sup>b</sup>	C <sub>o(tr)</sub>			-	64	-	
Total Gate Charge	Qg	V <sub>GS</sub> = 10 V I <sub>D</sub> = 4 A, V <sub>DS</sub> = 520 V		-	26		nC
Gate-Source Charge	Q <sub>gs</sub>			-	2.1	-	
Gate-Drain Charge	Q <sub>gd</sub>				2.8	-	
Turn-On Delay Time	t <sub>d(on)</sub>			-	26	-	
Rise Time	t <sub>r</sub>	V <sub>DD</sub> = 520 V, I <sub>D</sub> = 4 A,		-	55.7	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	00	= 10 V, $R_g = 9.1 \Omega$	-	71	-	- ns
Fall Time	t <sub>f</sub>			-	41	-	
Gate Input Resistance	R <sub>g</sub>	f = 1	MHz, open drain	-	3.5	-	Ω
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET sym showing the		-	-	7	
Pulsed Diode Forward Current	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	18	- A
Diode Forward Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 4 A, V <sub>GS</sub> = 0 V		-	-	1.4	V
Reverse Recovery Time	t <sub>rr</sub>	-		-	192	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25 \text{ °C}, I_F = I_S = 4 \text{ A},$		-	2.4	-	μC
Reverse Recovery Current	I <sub>RRM</sub>	dl/dt = 100 A/µs, V <sub>R</sub> = 400 V		11	_	A	

#### Notes

a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .





### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Fig. 2 - Typical Output Characteristics

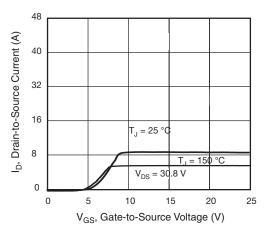


Fig. 3 - Typical Transfer Characteristics

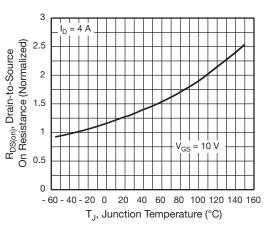


Fig. 4 - Normalized On-Resistance vs. Temperature

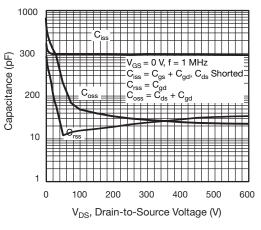


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

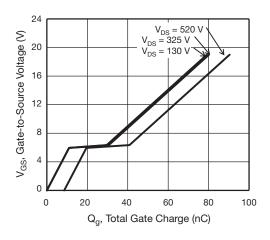


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

### **AOT11N70-VB**



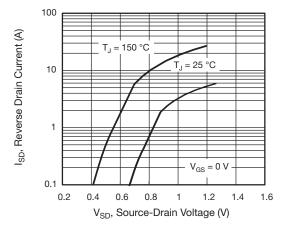


Fig. 7 - Typical Source-Drain Diode Forward Voltage

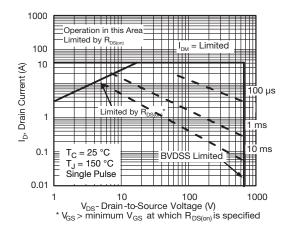


Fig. 8 - Maximum Safe Operating Area

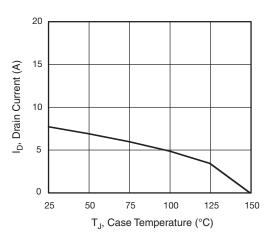


Fig. 9 - Maximum Drain Current vs. Case Temperature

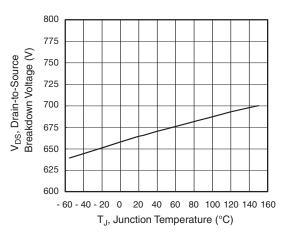


Fig. 10 - Temperature vs. Drain-to-Source Voltage

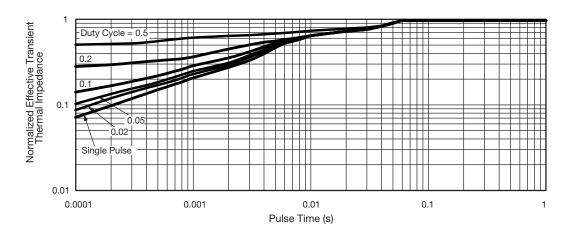


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



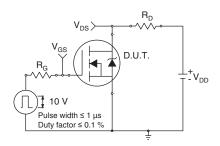


Fig. 12 - Switching Time Test Circuit

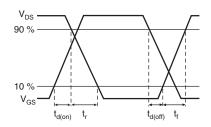


Fig. 13 - Switching Time Waveforms

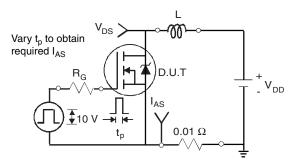


Fig. 14 - Unclamped Inductive Test Circuit

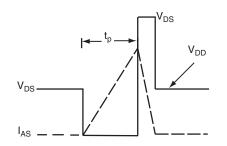


Fig. 15 - Unclamped Inductive Waveforms

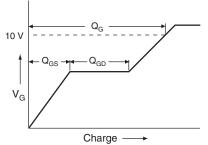


Fig. 16 - Basic Gate Charge Waveform

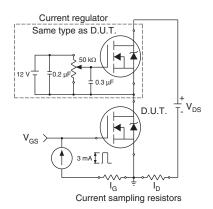
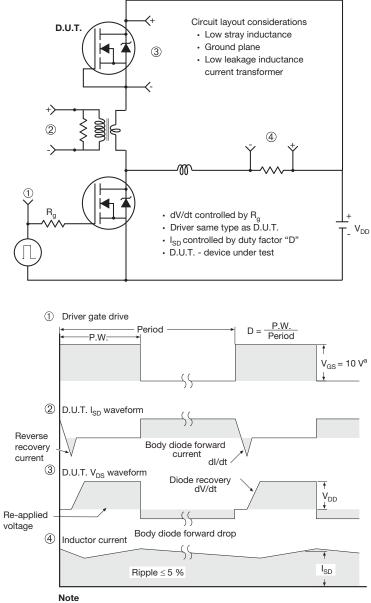


Fig. 17 - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit

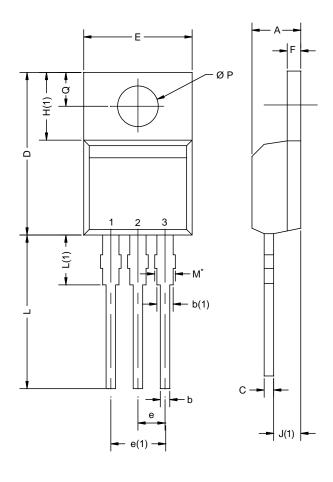


a.  $V_{GS} = 5 V$  for logic level devices

Fig. 18 - For N-Channel



# **TO-220AB**



	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	4.25	4.65	0.167	0.183
b	0.69	1.01	0.027	0.040
b(1)	1.20	1.73	0.047	0.068
С	0.36	0.61	0.014	0.024
D	14.85	15.49	0.585	0.610
Е	10.04	10.51	0.395	0.414
е	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.09	6.48	0.240	0.255
J(1)	2.41	2.92	0.095	0.115
L	13.35	14.02	0.526	0.552
L(1)	3.32	3.82	0.131	0.150
ØΡ	3.54	3.94	0.139	0.155
Q	2.60	3.00	0.102	0.118
ECN: X12- DWG: 547	0208-Rev. N, 1	08-Oct-12		

#### Notes

\* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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